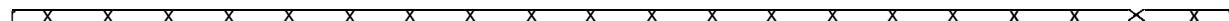


# LT024AD

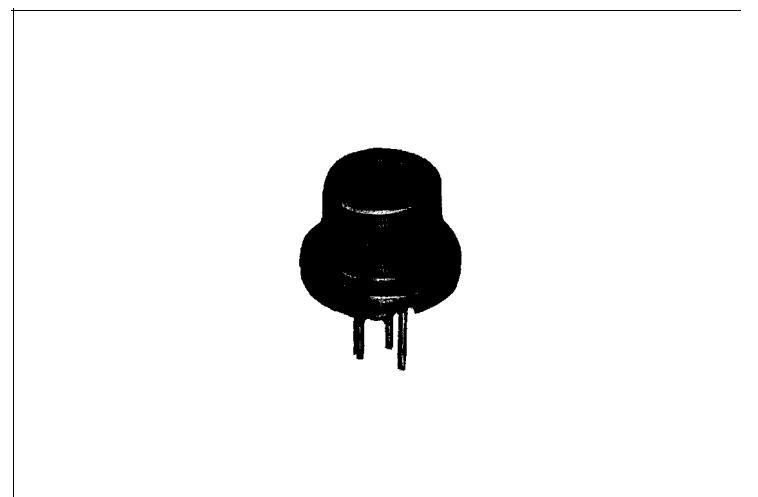


## Features

- High power (maximum optical power output: 35mW)
- Low noise: S/N -80 dB at superposed high frequency (according to measurement method Fig. 27-2)
- Wavelength: 780nm
- Single transverse mode

## Applications

- Optical disk memories
- Information processing equipment



## Absolute Maximum Ratings

( $T_c = 25^\circ\text{C}$ )

Parameter	Symbol	Ratings			Units
Optical power output	$P_o$	35			mW
Reverse voltage — Laser	$V_R$	2			v
PIN		30			
Operating temperatures'	$T_{opr}$	-10 to +60			$^\circ\text{C}$
Storage temperature**	$T_{stg}$	-40 to +85			$^\circ\text{C} \quad -1$

\* 1 Case temperature

## Electro-optical Characteristics \*\*

( $T_c = 25^\circ\text{C}$ )

Parameter	Symbol	Condition	Ratings			Units
			MIN	TYP	MAX	
Threshold current	$I_{th}$			60	85	mA
Operating current	$I_{op}$	$P_o = 30\text{mW}$		115	150	mA
Operating voltage	$V_{op}$	$P_o = 30\text{mW}$		1.8	2.2	v
Wavelength*	$\lambda_p$	$P_o = 30\text{mW}$	770	780	795	nm
Monitor current	$I_m$	$P_o = 30\text{mW}$ $V_R = 15\text{V}$	0.3	1.0	2.0	mA
Radiation characteristics	Angle * <sup>3</sup>	$\theta //$ Parallel to junction	Po=30mW	8	9.5	deg
		$\theta \perp$ Perpendicular to junction	Po=30mW	20	26	deg
		Ripple	Po=30mW		±20	%
Emission point accuracy	Angle	$\Delta\phi //$	Po=30mW		±2	deg
		$\Delta\phi \perp$	Po=30mW		±3	deg
	Position	$\Delta x, \Delta y, \Delta z$	Po=30mW		±80	$\mu\text{m}$
Differential efficiency	$\eta$	20mW	0.3	0.55	0.8	$\text{mW}/\text{mA}$
		$I_r(30\text{mW}) - I_r(10\text{mW})$				

\* 1 Initial value

\* 3 Angle at 50% peak intensity (full width at half-maximum)

\*\* 2 Single transverse mode

## Electrical Characteristics of Photodiode

( $T_c = 25^\circ\text{C}$ )

Parameter	Symbol	Condition	Ratings			Units
			MIN	TYP		
Sensitivity	$s$	$V_R = 15\text{V}$		33.3		$\text{mA}/\text{mW}$
Dark current	$I_D$	$V_R = 15\text{V}$				nA
Terminal capacitance	$C_t$	$V_R = 15\text{V}$		8		pF